



Sheet 1 of 2

Form PTO-1449 INFORMATION DISCLOSURE CITATION IN AN APPLICATION (Use several sheets if necessary)	Docket Number 20020604.ORI	Application Number 10/782,505
	Applicant James E. Blood	
	Filing Date Feb. 18, 2004	Group Art Unit

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Papers, Etc.)

LRO ↓ LRO	BGA (Ball Grid Array); National Semiconductor Application Note 1126, November 2002, AN-1126, pp. 1-10.
	Design Guid of the TAB tape Carrier for the BGA Packaging, TD 98-0917, Sept. 17, 1998, Hitachi Cable Ltd. (4 pp)
	Yanhong Tian and Chungqing Wang, Experimental Study on Laser and Hot Air Reflow Soldering of PBGA Solder Ball, IWC - Korea 2002, pp. 469-474
	Tape-Automated Bonding, March 1997, Said F. Al-sarawi, Centre for High Performance Integrated Technolgoies and Systems (2 pp)
	Wire Bonding Interconnection, March 1997, Said F. Al-sarawi, Centre for High Performance Integrated Technolgoies and Systems (2 pp)

EXAMINER	DATE CONSIDERED 3/12/05
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.	



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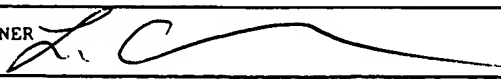
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Urb	Chenjian's Electronic Packaging, 1 pg.
Urb	TAB Tape Carrier with Micro Plating Bumps for Burn-in Testing Socket, Akira Chinda, et al., Hitachi Cable Review No. 20, August 2001, pp. 51-56.

EXAMINER 	DATE CONSIDERED 3/12/08
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